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Characterization of the PREF slow extraction parameters

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Providing 10 to 60 MeV proton beams, the PREF (Proton Radiation Effects Facility) is dedicated to the displacement damage effect experiments. The slow extracted beams from the synchrotron are delivered to two experimental terminals, which required the flux as constant as possible. To characterize the slow extraction parameters, scintillators and ionization chambers are equipped in the transport line and the terminals. The frequency response reveals the major influencing factor, power supply ripples. The duty factor reached over 90% shows the high slow extraction quality of the new accelerator.

Footnotes

Funding Agency

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Yes

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